


<b>Search Notes</b>  	<b>Application/Control No.</b>  10603520	<b>Applicant(s)/Patent Under Reexamination</b>  CHRISTIAN ET AL.
	<b>Examiner</b>  CHAU NGUYEN	<b>Art Unit</b>  2176

SEARCHED			
Class	Subclass	Date	Examiner
715	200	07/28/2008	cn
	204	07/28/2008	cn
	234	07/28/2008	cn
	243	07/28/2008	cn
	249	07/28/2008	cn
	255	07/28/2008	cn
	256	07/28/2008	cn
	264	07/28/2008	cn
	265	07/28/2008	cn

SEARCH NOTES		
Search Notes	Date	Examiner
Updated Search on East Reports	07/25/2008	cn
	07/28/2008	cn
Inventor Search for Double Patenting	07/29/2008	cn
NPL search on IEEE Database	07/28/2008	cn

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
715	200	07/28/2008	cn
	204	07/28/2008	cn
	234	07/28/2008	cn
	255	07/28/2008	cn
	256	07/28/2008	cn
	264	07/28/2008	cn
	265	07/28/2008	cn
Interference Search using PGPUB Database		07/28/2008	cn